

RF Test Report

For

Applicant Name: Address: EUT Name: Brand Name: Model Number:

Xwireless LLC 11565 Old Georgetown Road, Rockville, MD, USA Mobile Phone Vortex HD62

Issued By

Company Name:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen,
	China

Report Number: Test Standards: BTF230725R01101 47 CFR Part 15.247

Test Conclusion: FCC ID: Test Date: Date of Issue: Pass 2ADLJ-HD62 2023-07-26 to 2023-08-07 2023-08-08

Prepared By:

Elma. Kong

elma.yang / Project Engineer Lab (Shenzhen) C

Approved By:

Date:

Date:

Ryan.CJ / EMC Manager 2023-08-08

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Test Report Number: BTF230725R01101

Revision History			
Version	Issue Date	Revisions Content	
R_V0	2023-08-08	Original	
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Note: Once the revision has been made, then previous versions reports are invalid.

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1 Introduction

1.1 Identification of Testing Laboratory

Company Name: BTF Testing Lab (Shenzhen) Co., Ltd.		
Address: F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China		
Phone Number: +86-0755-23146130 Fax Number: +86-0755-23146130		

1.2 Identification of the Responsible Testing Location

Company Name: BTF Testing Lab (Shenzhen) Co., Ltd.	
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou
Address.	Community, Songgang Street, Bao'an District, Shenzhen, China
Phone Number:	+86-0755-23146130
Fax Number:	+86-0755-23146130
FCC Registration Number:	518915
Designation Number:	CN1330

1.3 Announcement

(1) The test report reference to the report template version v0.

(2) The test report is invalid if not marked with the signatures of the persons responsible for preparing, reviewing and approving the test report.

(3) The test report is invalid if there is any evidence and/or falsification.

(4) This document may not be altered or revised in any way unless done so by BTF and all revisions are duly noted in the revisions section.

(5) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.

(6) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.



2 **Product Information**

2.1 Application Information

Company Name:	Xwireless LLC		
Address:	11565 Old Georgetown Road, Rockville, MD, USA		
2.2 Manufacturer Int	formation		
Company Name:	Xwireless LLC		
Address: 11565 Old Georgetown Road, Rockville, MD, USA			
2.3 Factory Information	tion		
Company Name:	ZTECH COMMNICATION(SZ) CO LTD		
Address:	FL 7 BLOCK D BAO'AN ZHIGU INNOVATION PARK YIN'TIAN ROAD NO.4 XI'XIANG STR' BAO'AN DISTRICT SZ CHINA		
2.4 General Description of Equipment under Test (EUT)			

EUT Name:	Mobile Phone
Test Model Number:	HD62

2.5 Technical Information

DC 3.85V from Battery	
Input:100-240V 50/60Hz 0.3A Output:5.0V 2.0A 10.0W	
2402MHz to 2480MHz	
79	
GFSK, π/4 DQPSK, 8DPSK	
PIFA ANT	1.00
1.12dBi	
	Input:100-240V 50/60Hz 0.3A Output:5.0V 2.0A 10.0W 2402MHz to 2480MHz 79 GFSK, π/4 DQPSK, 8DPSK PIFA ANT

Note:

#: The antenna gain provided by the applicant, and the laboratory will not be responsible for the accumulated calculation results which covers the information provided by the applicant.



3 Summary of Test Results

3.1 Test Standards

The tests were performed according to following standards: **47 CFR Part 15.247:** Operation within the bands 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz

3.2 Uncertainty of Test

Item	Measurement Uncertainty
Conducted Emission (150 kHz-30 MHz)	±2.64dB
The following measurement uncertainty levels have been estimated for tests	s performed on the EUT as
specified in CISPR 16-4-2. This uncertainty represents an expanded uncert	ainty expressed at approximately

the 95% confidence level using a coverage factor of k=2.3.3 Summary of Test Result

Item	Standard	Requirement	Result
Antenna requirement	47 CFR Part 15.247	47 CFR 15.203	Pass
Conducted Emission at AC power line	47 CFR Part 15.247	47 CFR 15.207(a)	Pass
Occupied Bandwidth	47 CFR Part 15.247	47 CFR 15.215(c)	Pass
Maximum Conducted Output Power	47 CFR Part 15.247	47 CFR 15.247(b)(1)	Pass
Channel Separation	47 CFR Part 15.247	47 CFR 15.247(a)(1)	Pass
Number of Hopping Frequencies	47 CFR Part 15.247	47 CFR 15.247(a)(1)(iii)	Pass
Dwell Time	47 CFR Part 15.247	47 CFR 15.247(a)(1)(iii)	Pass
Emissions in non-restricted frequency bands	47 CFR Part 15.247	47 CFR 15.247(d)	Pass
Band edge emissions (Radiated)	47 CFR Part 15.247	47 CFR 15.247(d)	Pass
Emissions in restricted frequency bands (below 1GHz)	47 CFR Part 15.247	47 CFR 15.247(d)	Pass
Emissions in restricted frequency bands (above 1GHz)	47 CFR Part 15.247	47 CFR 15.247(d)	Pass

4 Test Configuration

4.1 Test Equipment List

Occupied Bandwidth Maximum Conducted Output Power Channel Separation Number of Hopping Frequencies Dwell Time Emissions in non-restricted frequency bands					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
RFTest software	1	V1.00	1	1	1
RF Control Unit	Techy	TR1029-1	1	2022-11-24	2023-11-23
RF Sensor Unit	Techy	TR1029-2	1	2022-11-24	2023-11-23
Programmable constant temperature and humidity box	ZZCKONG	ZZ-K02A	20210928007	2022-11-24	2023-11-23
Adjustable Direct Current Regulated Power Supply	Dongguan Tongmen Electronic Technology Co., LTD	etm-6050c	20211026123	2022-11-24	2023-11-23
WIDEBAND RADIO COMMNUNICATION TESTER	Rohde & Schwarz	CMW500	161997	2022-11-24	2023-11-23
MXA Signal Analyzer	KEYSIGHT	N9020A	MY50410020	2022-11-24	2023-11-23



	d frequency band	•	les contorne No	Cal Data	Col Due Det
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Coaxial cable Multiflex 141	Schwarzbeck	N/SMA 0.5m	517386	2023-03-24	2024-03-23
Preamplifier	SCHWARZBECK	BBV9744	00246	2022-11-24	2023-11-23
RE Cable	REBES Talent	UF1-SMASMAM-1 0m	21101566	2022-11-24	2023-11-23
RE Cable	REBES Talent	UF2-NMNM-10m	21101570	2022-11-24	2023-11-23
RE Cable	REBES Talent	UF1-SMASMAM-1 m	21101568	2022-11-24	2023-11-23
RE Cable REBES Tale		UF2-NMNM-1m	21101576	2022-11-24	2023-11-23
RE Cable	RE Cable REBES Talent		21101573	2022-11-24	2023-11-23
POSITIONAL CONTROLLER	SKET	PCI-GPIB	/	/	1
Horn Antenna	SCHWARZBECK	BBHA9170	01157	2021-11-28	2023-11-27
EMI TEST RECEIVER	ROHDE&SCHWA RZ	ESCI7	101032	2022-11-24	2023-11-23
SIGNAL ANALYZER	ROHDE&SCHWA RZ	FSQ40	100010	2022-11-24	2023-11-23
POSITIONAL CONTROLLER	SKET	PCI-GPIB	1	1	1
Broadband Preamplilifier	SCHWARZBECK	BBV9718D	00008	2023-03-24	2024-03-23
Horn Antenna	SCHWARZBECK	BBHA9120D	2597	2022-05-22	2024-05-21
EZ_EMC	Frad	FA-03A2 RE+	/	1	/
POSITIONAL CONTROLLER	SKET	PCI-GPIB	1	1	/
Log periodic antenna	SCHWARZBECK	VULB 9168	01328	2021-11-28	2023-11-27

Conducted Emission at AC power line							
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date		
Pulse Limiter	SCHWARZBECK	VTSD 9561-F	00953	2022-11-24	2023-11-23		
Coaxial Switcher	SCHWARZBECK	CX210	CX210	2022-11-24	2023-11-23		
V-LISN	SCHWARZBECK	NSLK 8127	01073	2022-11-24	2023-11-23		
LISN	AFJ	LS16/110VAC	16010020076	2023-02-23	2024-02-22		
EMI Receiver	ROHDE&SCHWA RZ	ESCI3	101422	2022-11-24	2023-11-23		

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4.2 Test Auxiliary Equipment

The EUT was tested as an independent device.

4.3 Test Modes

No.	Test Modes	Description
TM1	TX-GFSK	Keep the EUT in continuously transmitting mode (non-hopping) with GFSK modulation.
(Non-Hopping) TX-Pi/4DQPSK		Keep the EUT in continuously transmitting mode (non-hopping) with
TM2	(Non-Hopping)	Pi/4DQPSK modulation.
ТМ3	TX-8DPSK (Non-Hopping)	Keep the EUT in continuously transmitting mode (non-hopping) with 8DPSK modulation.
TM4	TX-GFSK (Hopping)	Keep the EUT in continuously transmitting mode (hopping) with GFSK modulation,.
TM5	TX-Pi/4DQPSK (Hopping)	Keep the EUT in continuously transmitting mode (hopping) with Pi/4DQPSK modulation.
TM6	TX-8DPSK (Hopping)	Keep the EUT in continuously transmitting mode (hopping) with 8DPSK modulation.



5 **Evaluation Results (Evaluation)**

Antenna requirement 5.1

	An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a
Test Requirement:	permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section.

6 **Radio Spectrum Matter Test Results (RF)**

Conducted Emission at AC power line 6.1

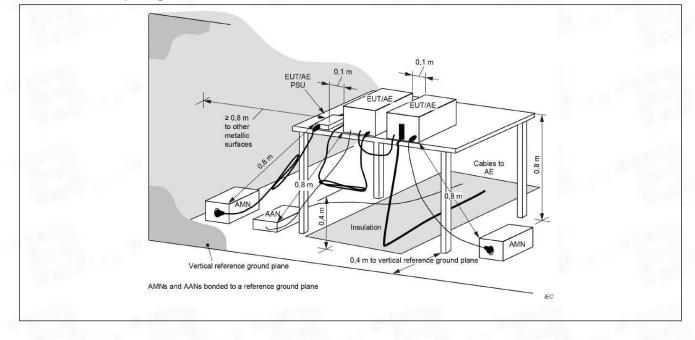
Test Requirement:	Refer to 47 CFR 15.207(a), Except as shown in paragraphs (b)and (c)of this section, for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50 μ H/50 ohms line impedance stabilization network (LISN).					
Test Method:	ANSI C63.10-2013 section 6.2 ANSI C63.10-2020 section 6.2					
	Frequency of emission (MHz)	Conducted limit (dBµV)				
		Quasi-peak	Average			
T CONTRACT	0.15-0.5	66 to 56*	56 to 46*			
Test Limit:	0.5-5	56	46			
	5-30	60	50			
	*Decreases with the logarithm of the frequency.					
Procedure:	Refer to ANSI C63.10-2013 section 6.2, standard test method for ac power-line conducted emissions from unlicensed wireless devices					
	Refer to ANSI C63.10-2020 section 6.2, standard test method for ac power-line conducted emissions from unlicensed wireless devices					

6.1.1 E.U.T. Operation:

Operating Environment:			
Temperature:	25.4 °C	1 m m	
Humidity:	45.1 %		
Atmospheric Pressure:	1010 mbar		1000



6.1.2 Test Setup Diagram:

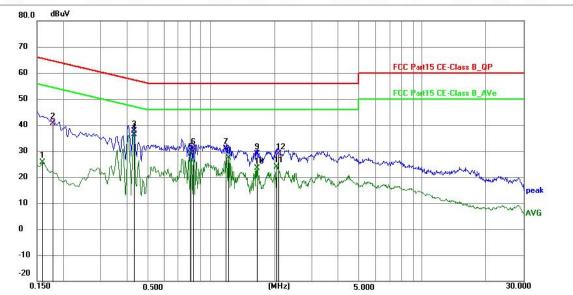


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6.1.3 Test Data:

TM1 / Line: Line / Band: 2.4G / BW: 1 / CH: M



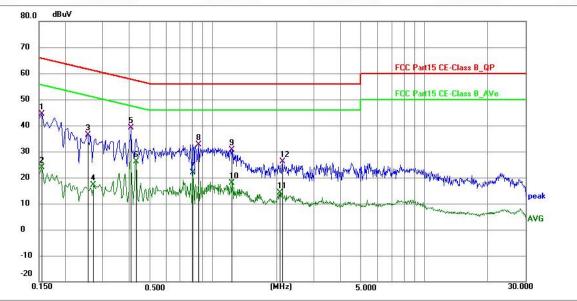
No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F	Remark
1	0.1590	15.03	10.55	25.58	55.52	-29.94	AVG	Р	
2	0.1770	30.14	10.56	40.70	64.63	-23.93	QP	Р	
3	0.4290	26.99	10.61	37.60	57.27	-19.67	QP	Р	
4 *	0.4290	25.78	10.61	36.39	47.27	-10.88	AVG	Р	
5	0.8070	18.15	10.75	28.90	46.00	-17.10	AVG	Р	
6	0.8295	20.15	10.75	30.90	56.00	-25.10	QP	Р	
7	1.1849	20.04	10.76	30.80	56.00	-25.20	QP	P	
8	1.2120	16.63	10.76	27.39	46.00	-18.61	AVG	Р	
9	1.6620	18.08	10.72	28.80	56.00	-27.20	QP	Р	
10	1.6620	12.57	10.72	23.29	46.00	-22.71	AVG	P	
11	2.0400	13.14	10.69	23.83	46.00	-22.17	AVG	Р	
12	2.0895	18.21	10.69	28.90	56.00	-27.10	QP	Р	

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TM1 / Line: Neutral / Band: 2.4G / BW: 1 / CH: M



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F	Remark
1	0.1544	33.88	10.55	44.43	65.76	-21.33	QP	Р	
2	0.1544	13.39	10.55	23.94	55.76	-31.82	AVG	Р	
3	0.2535	25.91	10.59	36.50	61.64	-25.14	QP	Р	
4	0.2714	6.55	10.59	17.14	51.07	-33.93	AVG	Р	
5 *	0.4063	28.54	10.60	39.14	57.72	-18.58	QP	Р	
6	0.4290	15.63	10.61	26.24	47.27	-21.03	AVG	Р	
7	0.8070	11.09	10.75	21.84	46.00	-24.16	AVG	P	
8	0.8610	21.96	10.76	32.72	56.00	-23.28	QP	Р	
9	1.2344	19.93	10.76	30.69	56.00	-25.31	QP	Р	
10	1.2344	7.22	10.76	17.98	46.00	-28.02	AVG	P	
11	2.0670	3.40	10.69	14.09	46.00	-31.91	AVG	Р	
12	2.1255	15.50	10.69	26.19	56.00	-29.81	QP	Р	

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6.2 Occupied Bandwidth

Test Requirement:	47 CFR 15.215(c)
	ANSI C63.10-2013, section 7.8.7, For occupied bandwidth measurements, use the procedure in 6.9.2.
Test Method:	ANSI C63.10-2020, section 7.8.6, For occupied bandwidth measurements, use the procedure in 6.9.3. Frequency hopping shall be disabled for this test. KDB 558074 D01 15.247 Meas Guidance v05r02
Test Limit:	Refer to 47 CFR 15.215(c), intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.
	 a) The spectrum analyzer center frequency is set to the nominal EUT channel center frequency. The span range for the EMI receiver or spectrum analyzer shall be between two times and five times the OBW. b) The nominal IF filter bandwidth (3 dB RBW) shall be in the range of 1% to 5% of the OBW and video bandwidth (VBW) shall be approximately three times RBW, unless otherwise specified by the applicable requirement.
	c) Set the reference level of the instrument as required, keeping the signal from exceeding the maximum input mixer level for linear operation. In general, the peak of the spectral envelope shall be more than [10 log (OBW/RBW)] below the reference level. Specific guidance is given in 4.1.5.2.
	 d) Steps a) through c) might require iteration to adjust within the specified tolerances. e) The dynamic range of the instrument at the selected RBW shall be more than 10 dB below the target "-xx dB down" requirement; that is, if the requirement calls for measuring the -20 dB OBW, the instrument noise floor at the selected RBW shall be at least 30 dB below the
Procedure:	reference value.f) Set detection mode to peak and trace mode to max hold.g) Determine the reference value: Set the EUT to transmit an unmodulated carrier or modulated signal, as applicable. Allow the trace to stabilize. Set the spectrum analyzer marker to the highest level of the displayed trace (this is the reference
	 value). h) Determine the "-xx dB down amplitude" using [(reference value) - xx]. Alternatively, this calculation may be made by using the marker-delta function of the instrument.
	i) If the reference value is determined by an unmodulated carrier, then turn the EUT modulation ON, and either clear the existing trace or start a new trace on the spectrum analyzer and allow the new trace to stabilize. Otherwise, the trace from step g) shall be used for step j).
	j) Place two markers, one at the lowest frequency and the other at the highest frequency of the envelope of the spectral display, such that each marker is at or slightly below the "-xx dB down amplitude" determined in step h). If a marker is
	below this "-xx dB down amplitude" value, then it shall be as close as possible to this value. The occupied bandwidth is the frequency difference between the two markers. Alternatively, set a marker at the lowest frequency of the envelope of the spectral display, such that the marker is at or slightly below the "-xx dB down
	amplitude" determined in step h). Reset the marker-delta function and move the marker to the other side of the emission until the delta marker amplitude is at the same level as the reference marker amplitude. The marker-delta frequency reading



at this point is the specified emission bandwidth.
k) The occupied bandwidth shall be reported by providing plot(s) of the measuring
instrument display; the plot axes and the scale units per division shall be clearly
labeled. Tabular data may be reported in addition to the plot(s).
The occupied bandwidth is the frequency bandwidth such that, below its lower and
above its upper frequency limits, the mean powers are each equal to 0.5% of the
total mean power of the given emission. The following procedure shall be used for
measuring 99% power bandwidth:
a) The instrument center frequency is set to the nominal EUT channel center
frequency. The frequency span for the spectrum analyzer shall be between 1.5 times and 5.0 times the OBW.
b) The nominal IF filter bandwidth (3 dB RBW) shall be in the range of 1% to 5% of
the OBW, and VBW shall be at least three times the RBW, unless otherwise
specified by the applicable requirement.
c) Set the reference level of the instrument as required, keeping the signal from
exceeding the maximum input mixer level for linear operation. In general, the peak
of the spectral envelope shall be more than [10 log (OBW/RBW)] below the
reference level. Specific guidance is given in 4.1.6.2.
d) Step a) through step c) might require iteration to adjust within the specified range.
e) Video averaging is not permitted. Where practical, a sample detection and single
sweep mode shall be used. Otherwise, peak detection and max-hold mode (until
the trace stabilizes) shall be used.
 f) Use the 99% power bandwidth function of the instrument (if available) and report the measured bandwidth.
g) If the instrument does not have a 99% power bandwidth function, then the trace
data points are recovered and directly summed in linear power terms. The
recovered amplitude data points, beginning at the lowest frequency, are placed in
running sum until 0.5% of the total is reached; that frequency is recorded as the
lower frequency. The process is repeated until 99.5% of the total is reached; that
frequency is recorded as the upper frequency. The 99% power bandwidth is the
difference between these two frequencies.
h) The occupied bandwidth shall be reported by providing spectral plot(s) of the
measuring instrument display; the plot axes and the scale units per division shall
be clearly labeled. Tabular data may be reported in addition to the plot(s).

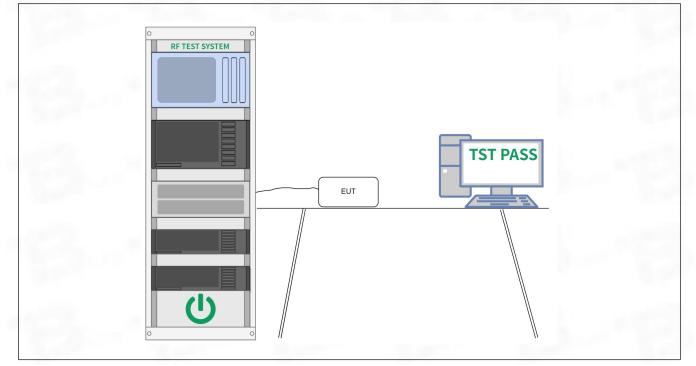
6.2.1 E.U.T. Operation:

Operating Environment:	
Temperature:	24.8 °C
Humidity:	53.7 %
Atmospheric Pressure:	1010 mbar

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6.2.2 Test Setup Diagram:



6.2.3 Test Data: Please Refer to Appendix for Details.

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6.3 Maximum Conducted Output Power

Test Requirement:	47 CFR 15.247(b)(1)
Test Method:	ANSI C63.10-2013, section 7.8.5 ANSI C63.10-2020, section 7.8.5 KDB 558074 D01 15.247 Meas Guidance v05r02
Test Limit:	Refer to 47 CFR 15.247(b)(1), For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.
Procedure:	This is an RF-conducted test to evaluate maximum peak output power. Use a direct connection between the antenna port of the unlicensed wireless device and the spectrum analyzer, through suitable attenuation. The hopping shall be disabled for this test: a) Use the following spectrum analyzer settings: 1) Span: Approximately five times the 20 dB bandwidth, centered on a hopping channel. 2) RBW > 20 dB bandwidth of the emission being measured. 3) VBW >= RBW. 4) Sweep: Auto. 5) Detector function: Peak. 6) Trace: Max hold. b) Allow trace to stabilize. c) Use the marker-to-peak function to set the marker to the peak of the emission. d) The indicated level is the peak output power, after any corrections for external attenuators and cables. e) A plot of the test results and setup description shall be included in the test report. NOTE—A peak responding power meter may be used, where the power meter and sensor system video bandwidth is greater than the occupied bandwidth of the unlicensed wireless device, rather than a spectrum analyzer. This is an RF-conducted test to evaluate maximum peak output power. Use a direct connection between the antenna port of the unlicensed wireless device and the spectrum analyzer, through suitable attenuation. Frequency hopping shall be disabled for this test. Use the following spectrum analyzer settings: a) Span: Approximately five times the 20 dB bandwidth, centered on a hopping channel. b) RBW > 20 dB bandwidth of the emission being measured. c) VBW ≥ RBW. d) Sweep: No faster than coupled (auto) time. e) Detector function: Peak. f) Trace: Max-hold. g) Allow trace to stabilize. h) Use the marker-to-peak function to set the marker to the peak of the emission. i) The indicated level is the peak output power, after any corrections for external attenuators and cables. i) A spectral plot of the test results and setup description shall be included in the test report. NOTE—A peak responding power meter may be used, where the power meter and sensor system video bandwidth of the emission being m

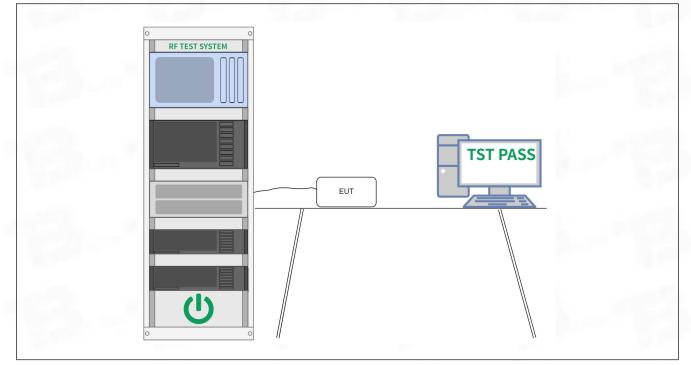
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6.3.1 E.U.T. Operation:

Operating Environment:	
Temperature:	24.8 °C
Humidity:	53.7 %
Atmospheric Pressure:	1010 mbar
	-

6.3.2 Test Setup Diagram:



6.3.3 Test Data:

Please Refer to Appendix for Details.



6.4 Channel Separation

Test Requirement:	47 CFR 15.247(a)(1)
Test Method:	ANSI C63.10-2013, section 7.8.2 ANSI C63.10-2020, section 7.8.2 KDB 558074 D01 15.247 Meas Guidance v05r02
Test Limit:	Refer to 47 CFR 15.247(a)(1), Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
Procedure:	 The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Wide enough to capture the peaks of two adjacent channels. b) RBW: Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel. c) Video (or average) bandwidth (VBW) ≥ RBW. d) Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. Compliance of an EUT with the appropriate regulatory limit shall be determined. A plot of the data shall be included in the test report. The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Wide enough to capture the peaks of two adjacent channels. b) RBW: Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel. c) Video (or average) bandwidth (VBW) ≥ RBW. d) Sweep: No faster than coupled (auto) time. e) Detector function: Peak. f) Trace: Max-hold. g) Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channel. c) Video (or average) bandwidth (VBW) ≥ RBW. d) Sweep: No faster than coupled (auto) time. e) Detector function: Peak. f) Trace: Max-hold. g) Allow the trace to stabilize.

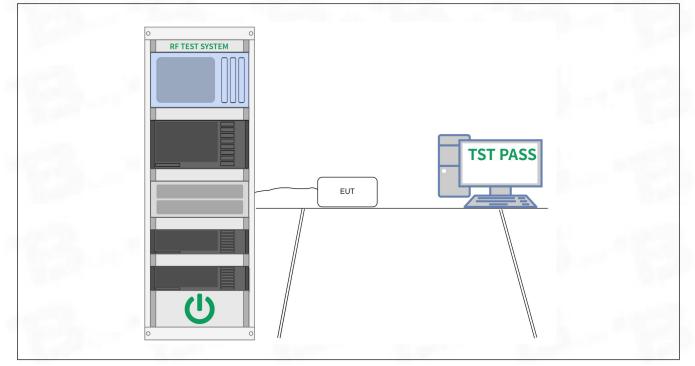
6.4.1 E.U.T. Operation:

Operating Environment:			
Temperature:	24.8 °C		
Humidity:	53.7 %		
Atmospheric Pressure:	1010 mbar		

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6.4.2 Test Setup Diagram:



6.4.3 Test Data: Please Refer to Appendix for Details.

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6.5 Number of Hopping Frequencies

Test Requirement:	47 CFR 15.247(a)(1)(iii)
Test Method:	ANSI C63.10-2013, section 7.8.3 ANSI C63.10-2020, section 7.8.3 KDB 558074 D01 15.247 Meas Guidance v05r02
Test Limit:	Refer to 47 CFR 15.247(a)(1)(iii), Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: The frequency band of operation. Depending on the number of channels the device supports, it may be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen. b) RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller. c) VBW ≥ RBW. d) Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize. It might prove necessary to break the span up into subranges to show clearly all of the hopping frequencies. Compliance of an EUT with the appropriate regulatory limit shall be determined for the number of hopping channels. A plot of the data shall be included in the test report.
Procedure:	 The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: The frequency band of operation. Depending on the number of channels the device supports, it could be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen. b) RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller. c) VBW ≥ RBW. d) Sweep: No faster than coupled (auto) time. e) Detector function: Peak. f) Trace: Max-hold. g) Allow the trace to stabilize. It might prove necessary to break the span up into subranges to show clearly all of the hopping frequencies. Compliance of an EUT with the appropriate regulatory limit shall be determined for the number of hopping channels. A spectral plot of the

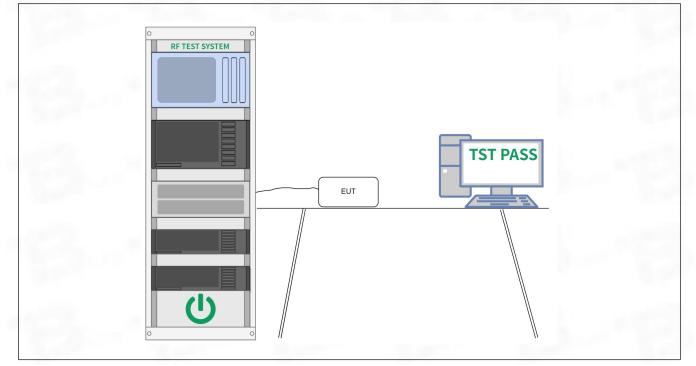
6.5.1 E.U.T. Operation:

Operating Environment:	
Temperature:	24.8 °C
Humidity:	53.7 %
Atmospheric Pressure:	1010 mbar

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6.5.2 Test Setup Diagram:



6.5.3 Test Data: Please Refer to Appendix for Details.



6.6 Dwell Time

Test Requirement:	47 CFR 15.247(a)(1)(iii)
Test Method:	ANSI C63.10-2013, section 7.8.4 ANSI C63.10-2020, section 7.8.4 KDB 558074 D01 15.247 Meas Guidance v05r02
Test Limit:	Refer to 47 CFR 15.247(a)(1)(iii), Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Zero span, centered on a hopping channel. b) RBW shall be <= channel spacing and where possible RBW should be set >> 1 / T, where T is the expected dwell time per channel. c) Sweep: As necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel; a second plot might be needed with a longer sweep time to show two successive hops on a channel. d) Detector function: Peak. e) Trace: Max hold. Use the marker-delta function to determine the transmit time per hop. If this value varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation in transmit time. Repeat the measurement using a longer sweep time to determine the number of hops over the period specified in the requirements. The sweep time shall be equal to, or less than, the period specified in the requirements, using the following equation: (Number of hops in the period specified in the requirements, using the following equation: (Number of hops in the period specified in the requirements, using the following equation. The average time of occupancy is calculated from the transmit time per hop multiplied by the number of hopps in the period specified in the requirements. If the number of hops in a specific time varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation. The measured transmit time and time between hops shall be consistent with the values described in the operational description for the EUT. The dwell time per hop on a channel is the time from the start of the first transmission to the end of the last transm



of occupancy the spectrum analyzer will be configured to measure both the dwell time per hop and the number of times the device transmits on a specific channel in a given period.
The EUT shall have its hopping function enabled. Compliance with the requirements shall be made with the minimum and with the maximum number of channels enabled. If the dwell time per channel does not vary with the number of channels than compliance with the requirements may be based on the minimum number of channels. If the device supports different dwell times per channel (example Bluetooth devices can dwell on a channel for 1, 3 or 5 time slots) then measurements can be limited to the longest dwell time with the minimum number of channels.
Use the following spectrum analyzer settings to determine the dwell time per hop:
 a) Span: Zero span, centered on a hopping channel. b) RBW shall be ≤ channel spacing and where possible RBW should be set >> 1 / T, where T is the expected transmission time per hop.
 c) Sweep time: Set so that the start of the first transmission and end of the last transmission for the hop are clearly captured. Setting the sweep time to be slightly longer than the hopping period per channel (hopping period = 1/hopping rate) should achieve this.
 d) Use a video trigger, where possible with a trigger delay, so that the start of the transmission is clearly observed. The trigger level might need adjustment to reduce the chance of triggering when the system hops on an adjacent channel. e) Detector function: Peak.
f) Trace: Clear-write, single sweep.g) Place markers at the start of the first transmission on the channel and at the end of the last transmission. The dwell time per hop is the time between these two markers.
To determine the number of hops on a channel in the regulatory observation period repeat the measurement using a longer sweep time. When the device uses a single hopping sequence the period of measurement should be sufficient to capture at least 2 hops. When the device uses a dynamic hopping sequence, or the sequence varies, the period of measurement may need to capture multiple hops to better determine the average time of occupancy. Count the number of hops on the channel across the sweep time.
The average number of hops on the same channel within the regulatory observation period is calculated from the number of hops on the channel divided by the spectrum analyzer sweep time multiplied by the regulatory observation period. For example, if three hops are counted with an analyzer sweep time of 500 ms and the regulatory observation period is 10 s, then the number of hops in that ten seconds is $3 / 0.5 \times 10$, or 60 hops.
The average time of occupancy is calculated by multiplying the dwell time per hop by the number of hops in the observation period.

6.6.1 E.U.T. Operation:

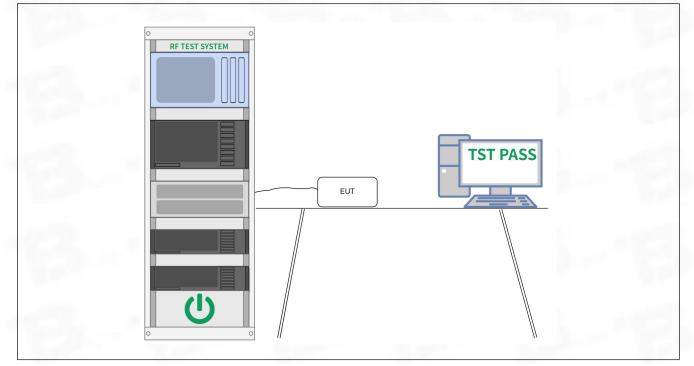
Operating Environment:	
Temperature:	24.8 °C
Humidity:	53.7 %
Atmospheric Pressure:	1010 mbar

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6.6.2 Test Setup Diagram:



6.6.3 Test Data: Please Refer to Appendix for Details.

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6.7 Emissions in non-restricted frequency bands

Test Requirement:	47 CFR 15.247(d)
Test Method:	ANSI C63.10-2013 section 7.8.8 ANSI C63.10-2020 section 7.8.7 KDB 558074 D01 15.247 Meas Guidance v05r02
Test Limit:	Refer to 47 CFR 15.247(d), In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in § 15.209(a) is not required.
	Conducted spurious emissions shall be measured for the transmit frequency, per 5.5 and 5.6, and at the maximum transmit powers. Connect the primary antenna port through an attenuator to the spectrum analyzer input; in the results, account for all losses between the unlicensed wireless device output and the spectrum analyzer. The instrument shall span 30 MHz to 10 times the operating frequency in GHz, with a resolution bandwidth of 100 kHz, video bandwidth of 300 kHz, and a coupled sweep time with a peak detector. The band 30 MHz to the highest frequency may be split into smaller spans, as long as the entire spectrum is covered.
	7.8.7.1 General considerations To demonstrate compliance with the relative out-of-band emissions requirements conducted spurious emissions shall be measured for the transmit frequencies, per 5.5 and 5.6, and at the maximum transmit powers. Frequency hopping shall be disabled for this test with the exception of measurements at the allocated band-edges which shall be repeated with hopping enabled.
Procedure:	Connect the primary antenna port through an attenuator to the spectrum analyzer input; in the results, account for all losses between the unlicensed wireless device output and the spectrum analyzer. The frequency range of testing shall span 30 MHz to 10 times the operating frequency and this may be done in a single sweep or, to aid resolution, across a number of sweeps. The resolution bandwidth shall be 100 kHz, video bandwidth 300 kHz, and a coupled sweep time with a peak detector.
	The limit is based on the highest in-band level across all channels measured using the same instrument settings (resolution bandwidth of 100 kHz, video bandwidth of 300 kHz, and a coupled sweep time with a peak detector). To help clearly demonstrate compliance a display line may be set at the required offset (typically 20 dB) below the highest in-band level. Where the highest in-band level is not clearly identified in the out-of-band measurements a separate spectral plot showing the in-band level shall be provided.
	When conducted measurements cannot be made (for example a device with integrated, non-removable antenna) radiated measurements shall be used. The reference level for determining the limit shall be established by maximizing the field strength from the highest power channel and measuring using the resolution and

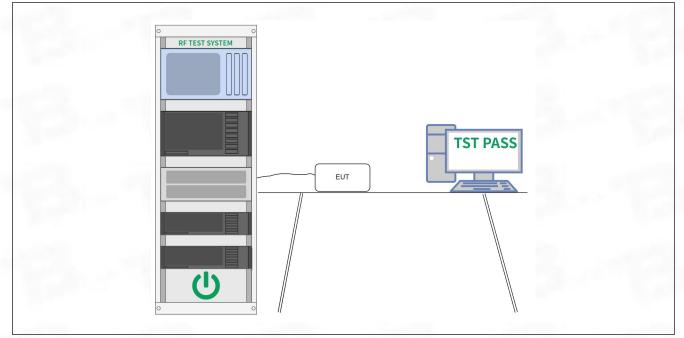


video bandwidth settings and peak detector as described above. The field strength limit for spurious emissions outside of restricted-bands shall then be set at the required offset (typically 20 dB) below the highest in-band level. Radiated
measurements will follow the standards measurement procedures described in Clause 6 with the exception that the resolution bandwidth shall be 100 kHz, video
bandwidth 300 kHz, and a coupled sweep time with a peak detector. Note that use of wider measurement bandwidths are acceptable for measuring the spurious
emissions provided that the peak detector is used and that the measured value of spurious emissions are compared to the highest in-band level measured with the 100 kHz / 300 kHz bandwidth settings to determine compliance.
7.8.7.2 Band-edges
Compliance with a relative limit at the band-edges (e.g., -20 dBc) shall be made on the lowest and on the highest channels with frequency hopping disabled and
repeated with frequency hopping enabled. For the latter test the hopping sequence shall include the lowest and highest channels.
For measurements with the hopping disabled the analyzer screen shall clearly show compliance with the requirement within 10 MHz of the allocated band-edge.
For measurements with the hopping enabled the analyzer screen shall clearly show compliance with the requirement within 10 MHz of both of the allocated
band-edges. This could require separate spectral plots for each band-edge.

6.7.1 E.U.T. Operation:

Operating Environment:			
Temperature:	24.8 °C	and the second se	
Humidity:	53.7 %		
Atmospheric Pressure:	1010 mbar		

6.7.2 Test Setup Diagram:



6.7.3 Test Data:

Please Refer to Appendix for Details.

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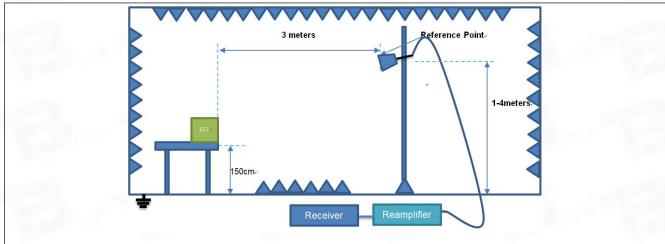
6.8 Band edge emissions (Radiated)

Test Requirement:	Refer to 47 CFR 15.247(d), In addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § $15.209(a)(see \ 15.205(c))$.			
Test Method:	ANSI C63.10-2013 section 6.10 ANSI C63.10-2020 section 6.10 KDB 558074 D01 15.247 Meas Guidance v05r02			
	Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (meters)	
	0.009-0.490	2400/F(kHz)	300	
	0.490-1.705	24000/F(kHz)	30	
	1.705-30.0	30	30	
	30-88	100 **	3	
Test Limit:	88-216	150 **	3	
	216-960	200 **	3	
	Above 960	500	3	
	** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241.			
Dracadura	ANSI C63.10-2013 secti	ANSI C63.10-2013 section 6.10.5.2		
Procedure:	ANSI C63.10-2020 sect	ANSI C63.10-2020 section 6.10.5.2		

6.8.1 E.U.T. Operation:

Operating Environment:	
Temperature:	25.4 °C
Humidity:	48.1 %
Atmospheric Pressure:	1010 mbar

6.8.2 Test Setup Diagram:



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6.8.3 Test Data:

TM1 / Polarization: Horizontal / Band: 2.4G / BW: 1 / CH: L

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	2310.000	67.44	-30.59	36.85	74.00	-37.15	peak	Р
2	2390.000	67.36	-30.49	36.87	74.00	-37.13	peak	Р
3 *	2400.000	69.81	-30.48	39.33	74.00	-34.67	peak	Р

TM1 / Polarization: Vertical / Band: 2.4G / BW: 1 / CH: L

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	2310.000	69.31	-30.59	38.72	74.00	-35.28	peak	Р
2	2390.000	68.40	-30.49	37.91	74.00	-36.09	peak	Р
3 *	2400.000	77.31	-30.48	46.83	74.00	-27.17	peak	Р

TM1 / Polarization: Horizontal / Band: 2.4G / BW: 1 / CH: H

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1 *	2483.500	76.55	-30.39	46.16	74.00	-27.84	peak	Р
2	2500.000	69.88	-30.37	39.51	74.00	-34.49	peak	Р

TM1 / Polarization: Vertical / Band: 2.4G / BW: 1 / CH: H

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	2483.500	70.00	-30.39	39.61	74.00	-34.39	peak	Р
2 *	2500.000	70.66	-30.37	40.29	74.00	-33.71	peak	Р



TM2 / Polarization: Horizontal / Band: 2.4G / BW: 1 / CH: L

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	2310.000	69.69	-30.59	39.10	74.00	-34.90	peak	Р
2	2390.000	68.89	-30.49	38.40	74.00	-35.60	peak	Р
3 *	2400.000	80.23	-30.48	49.75	74.00	-24.25	peak	Р

TM2 / Polarization: Vertical / Band: 2.4G / BW: 1 / CH: L

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	2310.000	69.01	-30.59	38.42	74.00	-35.58	peak	Р
2	2390.000	69.62	-30.49	39.13	74.00	-34.87	peak	Р
3 *	2400.000	77.39	-30.48	46.91	74.00	-27.09	peak	Р

TM2 / Polarization: Horizontal / Band: 2.4G / BW: 1 / CH: H

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	2483.500	71.00	-30.39	40.61	74.00	-33.39	peak	Р
2 *	2500.000	71.96	-30.37	41.59	74.00	-32.41	peak	Р

TM2 / Polarization: Vertical / Band: 2.4G / BW: 1 / CH: H

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1 *	2483.500	72.27	-30.39	41.88	74.00	-32.12	peak	Р
2	2500.000	71.25	-30.37	40.88	74.00	-33.12	peak	Р



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	2310.000	71.92	-30.59	41.33	74.00	-32.67	peak	Р
2	2390.000	69.85	-30.49	39.36	74.00	-34.64	peak	Р
3 *	2400.000	80.34	-30.48	49.86	74.00	-24.14	peak	Р

TM3 / Polarization: Horizontal / Band: 2.4G / BW: 1 / CH: L

TM3 / Polarization: Vertical / Band: 2.4G / BW: 1 / CH: L

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	2310.000	69.38	-30.59	38.79	74.00	-35.21	peak	Р
2	2390.000	70.31	-30.49	39.82	74.00	-34.18	peak	Р
3 *	2400.000	77.90	-30.48	47.42	74.00	-26.58	peak	Р

TM3 / Polarization: Horizontal / Band: 2.4G / BW: 1 / CH: H

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1 *	2483.500	74.97	-30.39	44.58	74.00	-29.42	peak	Р
2	2500.000	69.31	-30.37	38.94	74.00	-35.06	peak	Р

TM3 / Polarization: Vertical / Band: 2.4G / BW: 1 / CH: H

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1 *	2483.500	73.38	-30.39	42.99	74.00	-31.01	peak	Р
2	2500.000	70.53	-30.37	40.16	74.00	-33.84	peak	Р



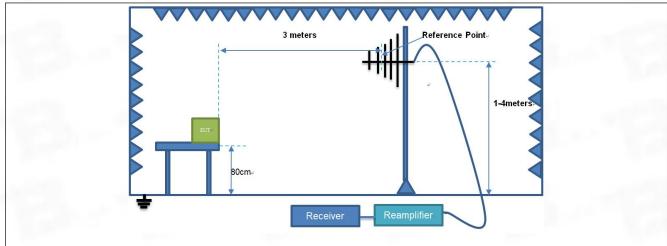
6.9 Emissions in restricted frequency bands (below 1GHz)

Test Requirement:	Refer to 47 CFR 15.247(d), In addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § 15.209(a)(see § 15.205(c)).`						
Test Method:	ANSI C63.10-2013 section 6.6.4 ANSI C63.10-2020 section 6.6.4 KDB 558074 D01 15.247 Meas Guidance v05r02						
	Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (meters)				
	0.009-0.490	2400/F(kHz)	300				
	0.490-1.705	24000/F(kHz)	30				
	1.705-30.0	30	30				
	30-88	100 **	3				
Test Limit:	88-216	150 **	3				
	216-960	200 **	3				
	Above 960	500	3				
	radiators operating unde 54-72 MHz, 76-88 MHz,	** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241.					
Procedure:	ANSI C63.10-2013 section 6.6.4						
	ANSI C63.10-2020 section 6.6.4						

6.9.1 E.U.T. Operation:

Operating Environment:	
Temperature:	25.4 °C
Humidity:	48.1 %
Atmospheric Pressure:	1010 mbar

6.9.2 Test Setup Diagram:



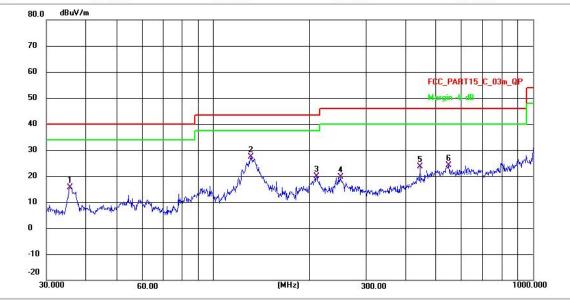
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6.9.3 Test Data:

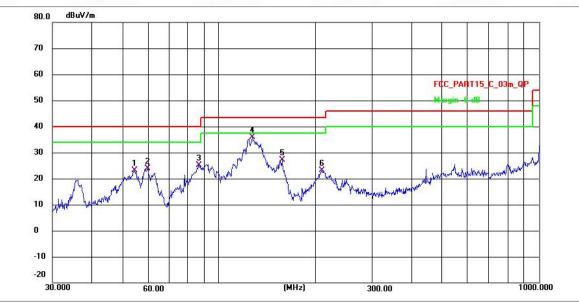
Note: All the mode have been tested, and only the worst mode are in the report TM1 / Polarization: Horizontal / Band: 2.4G / BW: 1 / CH: L



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	35.6865	34.14	-18.46	15.68	40.00	-24.32	QP	Р
2 *	131.5268	55.21	-27.95	27.26	43.50	-16.24	QP	Р
3	210.4168	46.66	-26.88	19.78	43.50	-23.72	QP	Р
4	249.8627	45.58	-25.85	19.73	46.00	-26.27	QP	Р
5	442.5177	46.18	-22.64	23.54	46.00	-22.46	QP	Р
6	546.1393	45.83	-21.62	24.21	46.00	-21.79	QP	Р

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TM1 / Polarization: Vertical / Band: 2.4G / BW: 1 / CH: L

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	54.3562	43.34	-20.25	23.09	40.00	-16.91	QP	Р
2	59.6493	43.93	-20.16	23.77	40.00	-16.23	QP	Р
3	86.5029	42.69	-17.55	25.14	40.00	-14.86	QP	Р
4 *	126.9948	50.27	-14.31	35.96	43.50	-7.54	QP	Р
5	157.0074	41.53	-14.38	27.15	43.50	-16.35	QP	Р
6	210.0482	38.83	-15.62	23.21	43.50	-20.29	QP	Р



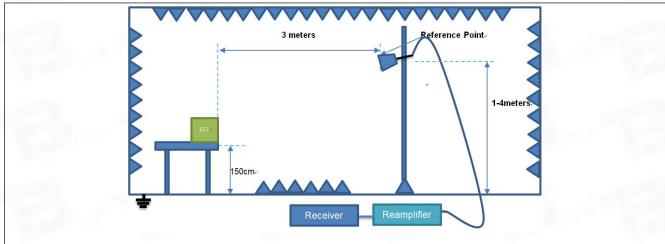
6.10 Emissions in restricted frequency bands (above 1GHz)

Test Requirement:	In addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § 15.209(a)(see § 15.205(c)).						
Test Method:	ANSI C63.10-2013 section 6.6.4 ANSI C63.10-2020 section 6.6.4 KDB 558074 D01 15.247 Meas Guidance v05r02						
	Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (meters)				
	0.009-0.490	2400/F(kHz)	300				
	0.490-1.705	24000/F(kHz)	30				
	1.705-30.0	30	30				
	30-88	100 **	3				
Test Limit:	88-216	150 **	3				
	216-960	200 **	3				
	Above 960	500	3				
	radiators operating unde 54-72 MHz, 76-88 MHz,	** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., \S 15.231 and 15.241.					
Procedure:	ANSI C63.10-2013 section 6.6.4						
	ANSI C63.10-2020 section 6.6.4						

6.10.1 E.U.T. Operation:

Operating Environment:	
Temperature:	25.4 °C
Humidity:	48.1 %
Atmospheric Pressure:	1010 mbar

6.10.2 Test Setup Diagram:



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6.10.3 Test Data:

TM1 / Polarization: Horizontal / Band: 2.4G / BW: 1 / CH: L

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	4548.711	66.64	-28.64	38.00	74.00	-36.00	peak	Р
2	6179.413	68.09	-25.35	42.74	74.00	-31.26	peak	Р
3	7591.413	71.72	-24.91	46.81	74.00	-27.19	peak	Р
4	10203.214	73.54	-24.38	49.16	74.00	-24.84	peak	Р
5	13093.839	71.27	-21.27	50.00	74.00	-24.00	peak	Р
6 *	15376.594	72.49	-21.23	51.26	74.00	-22.74	peak	Р

TM1 / Polarization: Vertical / Band: 2.4G / BW: 1 / CH: L

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	3398.062	64.54	-29.15	35.39	74.00	-38.61	peak	Р
2	4529.032	62.76	-28.71	34.05	74.00	-39.95	peak	Р
3	7206.555	68.05	-24.87	43.18	74.00	-30.82	peak	Р
4	8809.863	70.24	-24.69	45.55	74.00	-28.45	peak	Р
5	11031.367	70.66	-23.41	47.25	74.00	-26.75	peak	Р
6 *	14677.438	73.22	-20.92	52.30	74.00	-21.70	peak	Р

TM1 / Polarization: Horizontal / Band: 2.4G / BW: 1 / CH: M

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	4446.023	62.43	-28.81	33.62	74.00	-40.38	peak	Р
2	5488.846	62.94	-26.96	35.98	74.00	-38.02	peak	Р
3	6902.782	65.85	-25.02	40.83	74.00	-33.17	peak	Р
4	8202.834	71.08	-25.45	45.63	74.00	-28.37	peak	Р
5 *	11221.100	74.06	-23.28	50.78	74.00	-23.22	peak	Р
6	15997.694	67.55	-21.59	45.96	74.00	-28.04	peak	Р

TM1 / Polarization: Vertical / Band: 2.4G / BW: 1 / CH: M

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	3764.159	61.64	-29.03	32.61	74.00	-41.39	peak	Р
2	5168.581	61.21	-27.23	33.98	74.00	-40.02	peak	Р
3	6652.068	65.53	-25.24	40.29	74.00	-33.71	peak	Р
4	9326.056	66.63	-23.58	43.05	74.00	-30.95	peak	Р
5	12958.300	70.02	-21.37	48.65	74.00	-25.35	peak	Р
6 *	15804.663	72.93	-21.55	51.38	74.00	-22.62	peak	Р

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No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	3877.906	60.46	-29.02	31.44	74.00	-42.56	peak	Р
2	6373.509	65.12	-25.37	39.75	74.00	-34.25	peak	Р
3	8202.834	65.08	-25.45	39.63	74.00	-34.37	peak	Р
4	9984.411	66.95	-24.26	42.69	74.00	-31.31	peak	Р
5	12287.146	69.12	-21.86	47.26	74.00	-26.74	peak	Р
6 *	16193.083	72.80	-20.66	52.14	74.00	-21.86	peak	Р

TM1 / Polarization: Horizontal / Band: 2.4G / BW: 1 / CH: H

TM1 / Polarization: Vertical / Band: 2.4G / BW: 1 / CH: H

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	4375.903	60.64	-28.84	31.80	74.00	-42.20	peak	Р
2	5866.138	61.54	-25.77	35.77	74.00	-38.23	peak	Р
3	7237.867	61.79	-24.86	36.93	74.00	-37.07	peak	Р
4	8784.436	63.74	-24.74	39.00	74.00	-35.00	peak	Р
5	13139.333	66.85	-21.24	45.61	74.00	-28.39	peak	Р
6 *	15804.663	70.93	-21.55	49.38	74.00	-24.62	peak	Р

TM2 / Polarization: Horizontal / Band: 2.4G / BW: 1 / CH: L

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	3657.975	60.43	-29.03	31.40	74.00	-42.60	peak	Р
2	5237.760	65.26	-27.17	38.09	74.00	-35.91	peak	Р
3	7169.159	65.44	-24.88	40.56	74.00	-33.44	peak	Р
4	9566.309	70.33	-23.34	46.99	74.00	-27.01	peak	Р
5	13315.197	69.55	-21.10	48.45	74.00	-25.55	peak	Р
6 *	17043.071	68.42	-18.11	50.31	74.00	-23.69	peak	Р

TM2 / Polarization: Vertical / Band: 2.4G / BW: 1 / CH: L

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	4843.148	61.84	-27.82	34.02	74.00	-39.98	peak	Р
2	6120.752	63.18	-25.34	37.84	74.00	-36.16	peak	Р
3	7074.471	64.26	-24.91	39.35	74.00	-34.65	peak	Р
4	9445.418	65.64	-23.32	42.32	74.00	-31.68	peak	Р
5	12044.523	70.53	-22.14	48.39	74.00	-25.61	peak	Р
6 *	15781.839	71.46	-21.55	49.91	74.00	-24.09	peak	Р

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No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	5317.078	65.80	-27.11	38.69	74.00	-35.31	peak	Р
2	6916.762	66.58	-25.01	41.57	74.00	-32.43	peak	Р
3	7757.775	69.75	-25.16	44.59	74.00	-29.41	peak	Р
4	9049.887	71.10	-24.20	46.90	74.00	-27.10	peak	Р
5	11221.100	71.56	-23.28	48.28	74.00	-25.72	peak	Р
6 *	16109.054	71.09	-21.07	50.02	74.00	-23.98	peak	Р

TM2 / Polarization: Horizontal / Band: 2.4G / BW: 1 / CH: M

TM2 / Polarization: Vertical / Band: 2.4G / BW: 1 / CH: M

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	4219.405	62.07	-28.90	33.17	74.00	-40.83	peak	Р
2	5272.696	65.33	-27.15	38.18	74.00	-35.82	peak	Р
3 *	8195.724	74.71	-25.45	49.26	74.00	-24.74	peak	Р
4	10366.711	72.87	-24.46	48.41	74.00	-25.59	peak	Р
5	13575.565	68.94	-20.98	47.96	74.00	-26.04	peak	Р
6	16476.356	62.33	-19.29	43.04	74.00	-30.96	peak	Р

TM2 / Polarization: Horizontal / Band: 2.4G / BW: 1 / CH: H

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	4112.248	65.34	-28.95	36.39	74.00	-37.61	peak	Р
2	5427.320	66.47	-27.01	39.46	74.00	-34.54	peak	Р
3	7177.452	69.01	-24.88	44.13	74.00	-29.87	peak	Р
4	9094.465	69.42	-24.10	45.32	74.00	-28.68	peak	Р
5	13462.249	70.43	-20.99	49.44	74.00	-24.56	peak	Р
6 *	16338.827	69.90	-19.96	49.94	74.00	-24.06	peak	Р

TM2 / Polarization: Vertical / Band: 2.4G / BW: 1 / CH: H

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	3609.662	61.16	-29.05	32.11	74.00	-41.89	peak	Р
2	4773.658	60.26	-28.01	32.25	74.00	-41.75	peak	Р
3	6218.832	63.56	-25.35	38.21	74.00	-35.79	peak	Р
4	7322.033	65.53	-24.83	40.70	74.00	-33.30	peak	Р
5	11387.735	69.89	-23.15	46.74	74.00	-27.26	peak	Р
6 *	14618.166	70.41	-21.01	49.40	74.00	-24.60	peak	Р

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No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	3237.000	66.51	-29.29	37.22	74.00	-36.78	peak	Р
2	5414.785	70.22	-27.02	43.20	74.00	-30.80	peak	Р
3	7080.608	71.61	-24.91	46.70	74.00	-27.30	peak	Р
4 *	8497.247	75.68	-25.32	50.36	74.00	-23.64	peak	Р
5	11430.604	73.38	-23.11	50.27	74.00	-23.73	peak	Р
6	15781.839	69.46	-21.55	47.91	74.00	-26.09	peak	Р

TM3 / Polarization: Horizontal / Band: 2.4G / BW: 1 / CH: L

TM3 / Polarization: Vertical / Band: 2.4G / BW: 1 / CH: L

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	4644.364	64.05	-28.37	35.68	74.00	-38.32	peak	Р
2	5580.024	66.66	-26.69	39.97	74.00	-34.03	peak	Р
3	7001.240	69.47	-24.93	44.54	74.00	-29.46	peak	Р
4	7786.979	70.90	-25.21	45.69	74.00	-28.31	peak	Р
5	10088.844	73.98	-24.33	49.65	74.00	-24.35	peak	Р
6 *	14304.686	72.01	-21.15	50.86	74.00	-23.14	peak	Р

TM3 / Polarization: Horizontal / Band: 2.4G / BW: 1 / CH: M

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	3624.298	62.98	-29.04	33.94	74.00	-40.06	peak	Р
2	6334.940	68.16	-25.36	42.80	74.00	-31.20	peak	Р
3	8228.955	69.00	-25.43	43.57	74.00	-30.43	peak	Р
4 *	10420.786	73.36	-24.48	48.88	74.00	-25.12	peak	Р
5	11613.769	71.37	-22.86	48.51	74.00	-25.49	peak	Р
6	16871.527	65.00	-18.51	46.49	74.00	-27.51	peak	Р

TM3 / Polarization: Vertical / Band: 2.4G / BW: 1 / CH: M

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	4943.564	59.48	-27.53	31.95	74.00	-42.05	peak	Р
2	6549.048	65.83	-25.34	40.49	74.00	-33.51	peak	Р
3	7659.739	67.00	-25.02	41.98	74.00	-32.02	peak	Р
4	9883.915	69.81	-24.04	45.77	74.00	-28.23	peak	Р
5	12516.553	67.86	-21.60	46.26	74.00	-27.74	peak	Р
6 *	15604.938	73.02	-21.51	51.51	74.00	-22.49	peak	Р

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TM3 / Polarization: Horizontal / Band: 2.4G / BW: 1 / CH: H

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	3609.662	59.16	-29.05	30.11	74.00	-43.89	peak	Р
2	6172.273	67.25	-25.35	41.90	74.00	-32.10	peak	Р
3	7400.758	70.62	-24.81	45.81	74.00	-28.19	peak	Р
4	8761.614	70.61	-24.79	45.82	74.00	-28.18	peak	Р
5	11906.073	69.91	-22.35	47.56	74.00	-26.44	peak	Р
6 *	15960.745	73.81	-21.59	52.22	74.00	-21.78	peak	Р

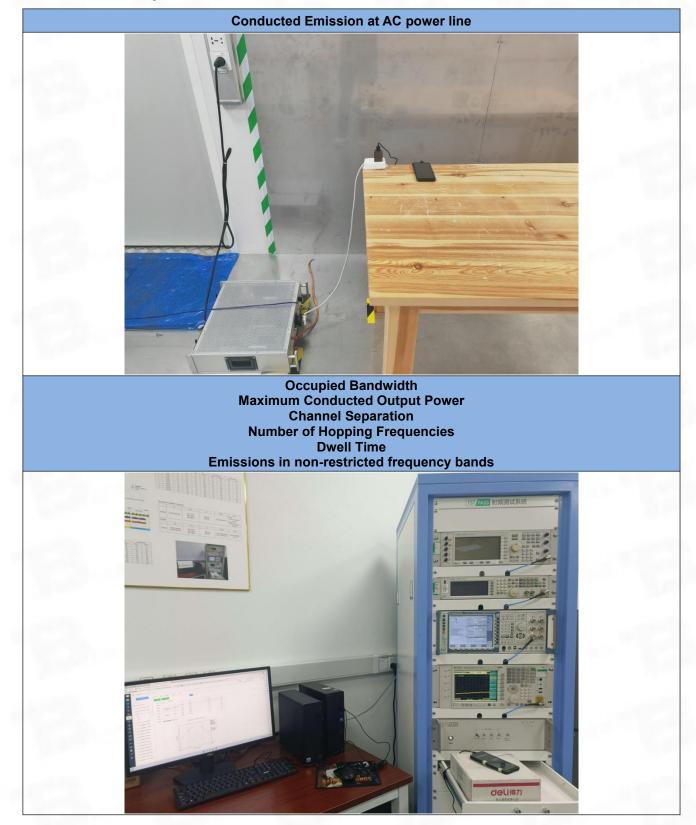
TM3 / Polarization: Vertical / Band: 2.4G / BW: 1 / CH: H

	Fraguanay	Reading	Factor	Level	Limit	Margin		
No.	Frequency (MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dBuV/m)	Margin (dB)	Detector	P/F
1	3447.527	57.94	-29.10	28.84	74.00	-45.16	peak	Р
2	5221.134	61.78	-27.19	34.59	74.00	-39.41	peak	Р
3	6386.417	65.42	-25.36	40.06	74.00	-33.94	peak	Р
4	7235.775	65.25	-24.86	40.39	74.00	-33.61	peak	Р
5	10182.591	68.23	-24.37	43.86	74.00	-30.14	peak	Р
6 *	15283.544	73.42	-21.02	52.40	74.00	-21.60	peak	Р

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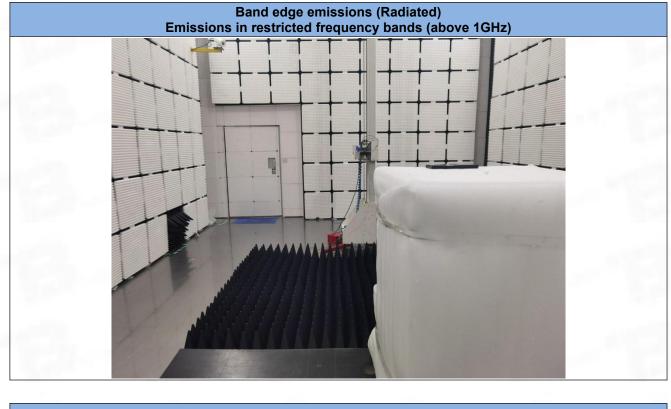


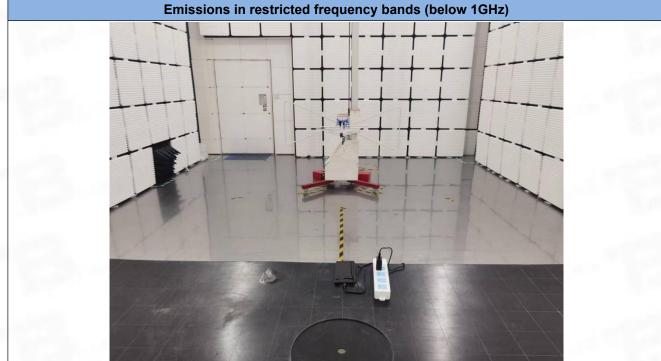
7 Test Setup Photos



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8 EUT Constructional Details (EUT Photos)

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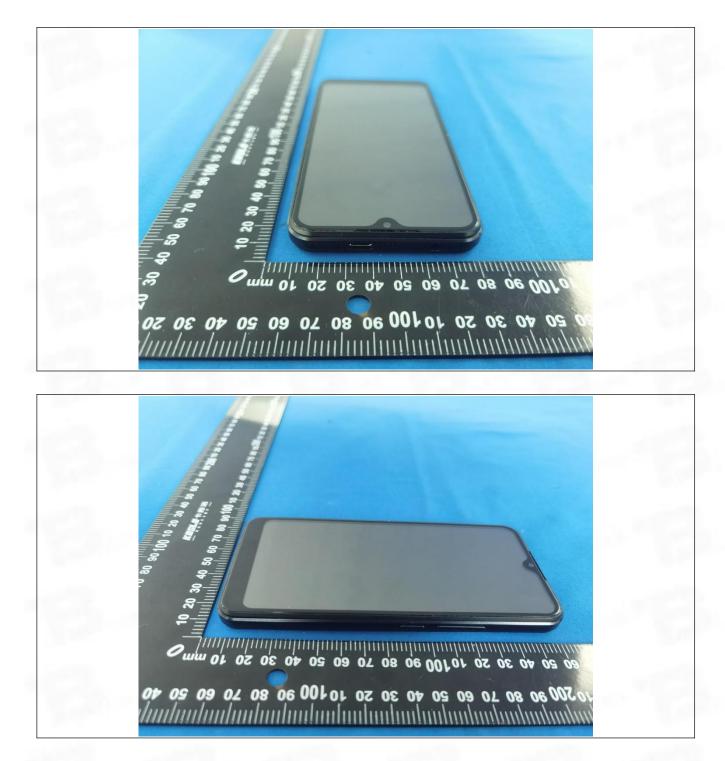


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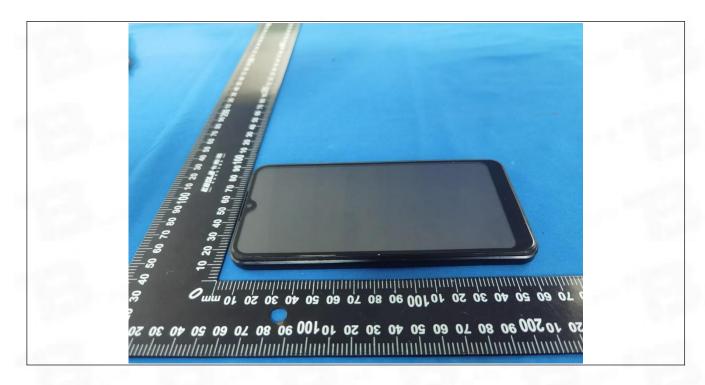
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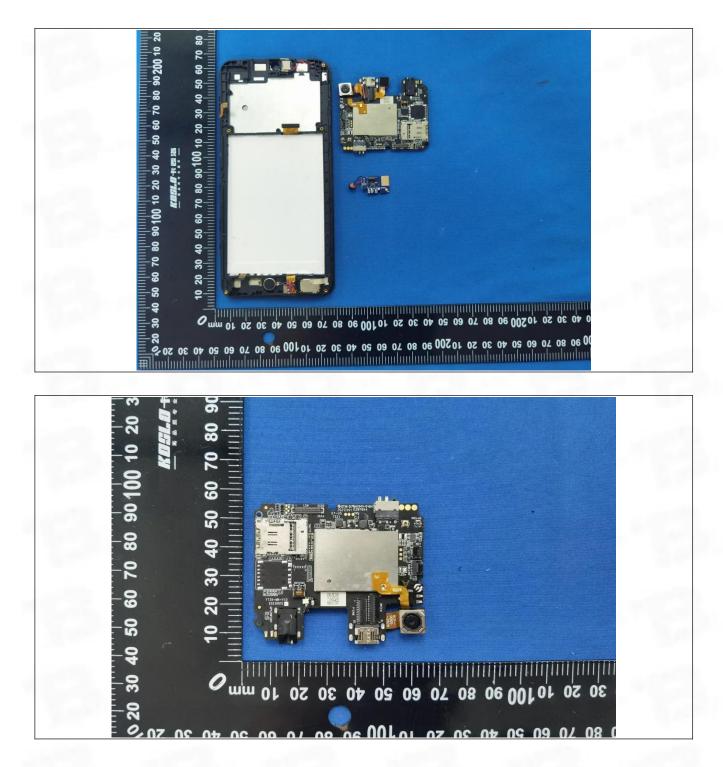
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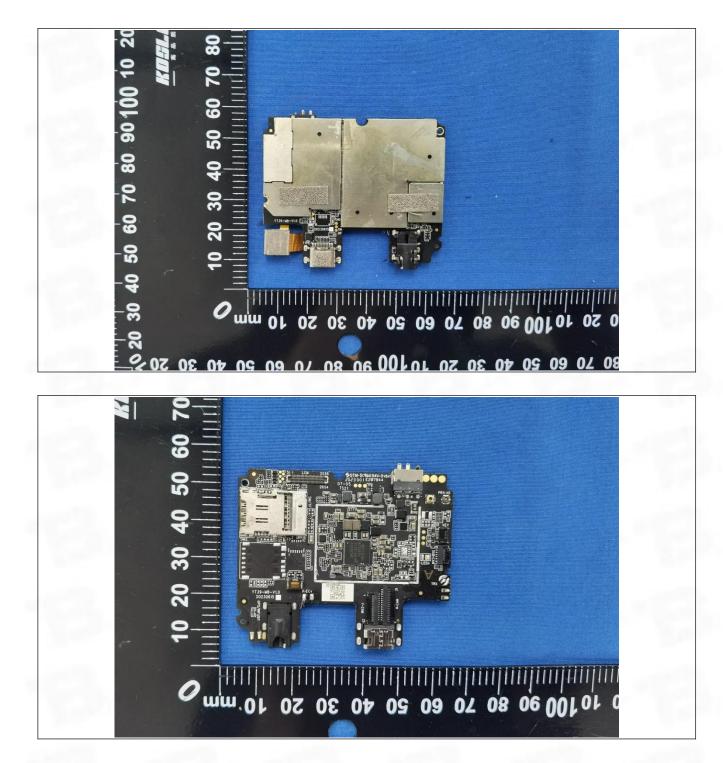
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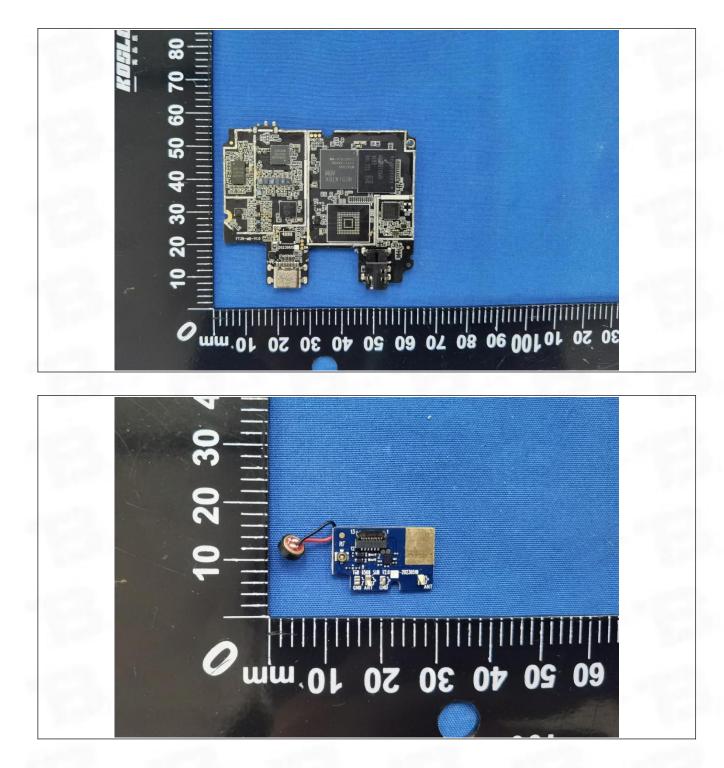




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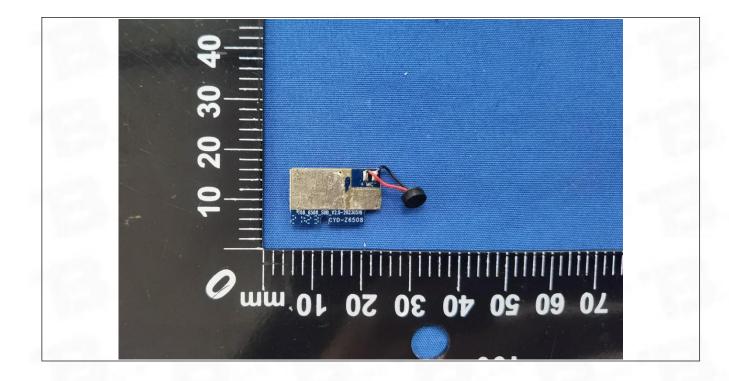




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Appendix

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1. Bandwidth

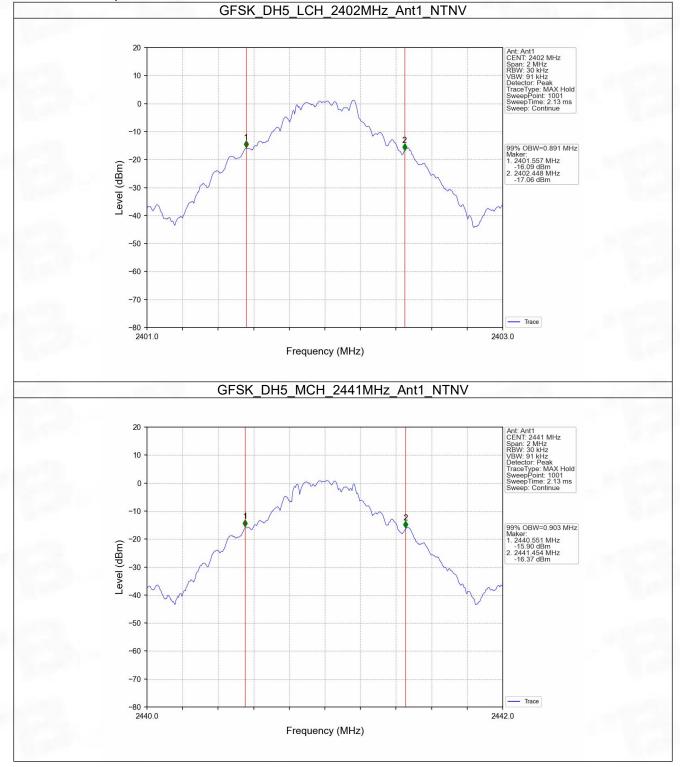
1.1 OBW

1.1.1 Test Result

Mode	ТХ Туре	Frequency (MHz)	Packet Type	ANT	99% Occupied Bandwidth (MHz) Result	Verdict
		2402	DH5	1	0.891	Pass
GFSK	SISO	2441	DH5	1	0.903	Pass
2		2480	DH5	1	0.902	Pass
	1.00	2402	2DH5	1	1.185	Pass
Pi/4DQPSK	SISO	2441	2DH5	1	1.154	Pass
		2480	2DH5	1	1.171	Pass
		2402	3DH5	1	1.189	Pass
8DPSK	SISO	2441	3DH5	1	1.190	Pass
		2480	3DH5	1	1.181	Pass

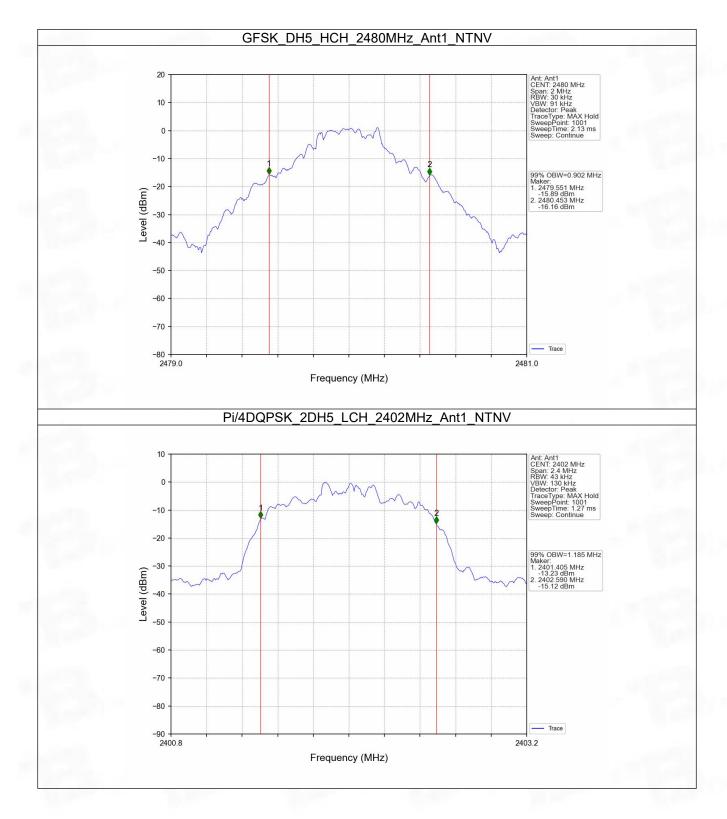


1.1.2 Test Graph



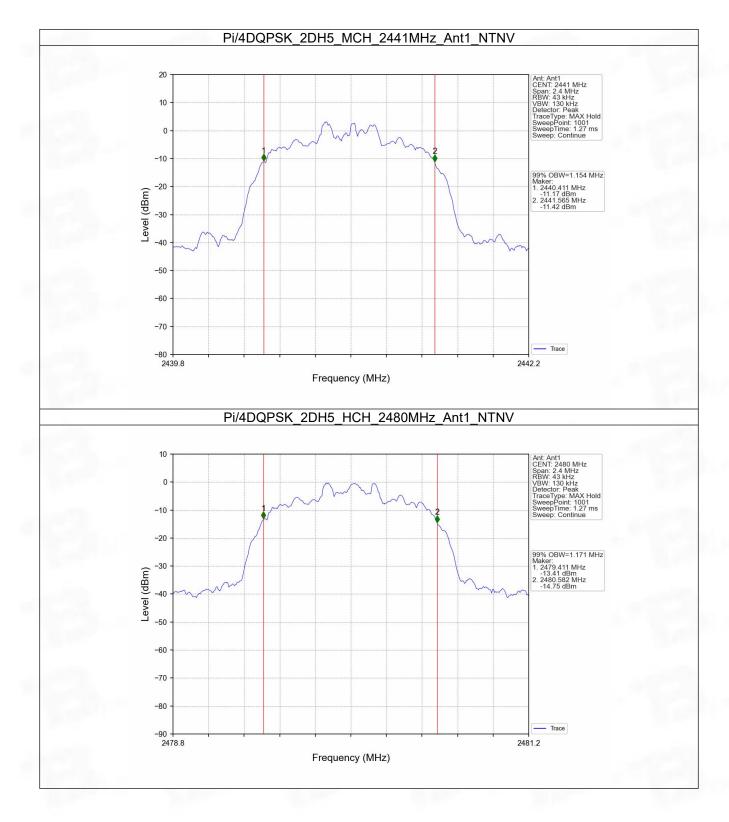
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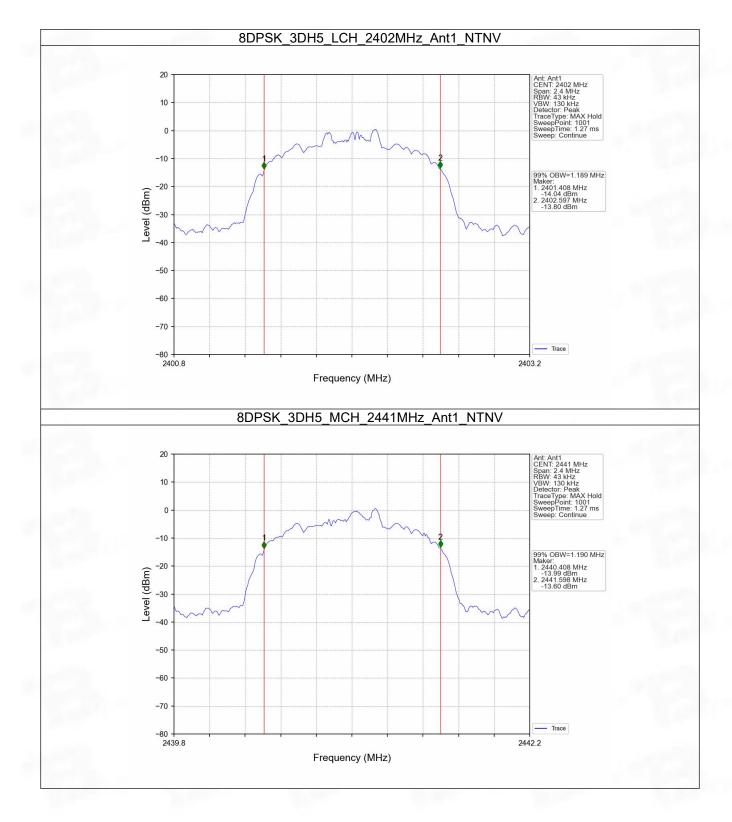
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